Search Notes

Applic	cation/Control No.	Applicant(s)/Patent u Reexamination	nder
09/66	6,859	MURAKAMI ET AL.	
Exami	ner	Art Unit	
Philip	C. Lee	2154	

SEARCHED						
Class	Subclass	Date	Examiner			
709	200	7/13/2005	PL			
709	204	7/13/2005	PL			
706	45	7/14/2005	PL			
709	224	7/14/2005	PL			
709	205	7/16/2005	PL			
345	349	7/16/2005	PL			
			-			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
709	200	7/16/2005	PL		
709	204	7/16/2005	Pr		
709	224	7/16/2005	PL		
345/349		7/16/2005	PL		

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Consulted with SPE: John Follansbee	7/16/2005	PL
Consulted with Primary: Nabil El Hady	7/18/2005	PL
Inventor/Assignee Search	7/18/2005	PL
Keywords Search in EAST	7/13/2005	PL
Keywords Search in EAST	7/14/2005	PL
Keywords Search in EAST	7/16/2005	PL
Google Search	7/22/2005	PL
IEEE/ACM Search	7/22/2005	PL